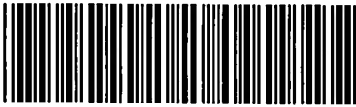


Search Notes

Application/Control No.

10/533,247

Examiner

BINH K. TIEU

Applicant(s)/Patent under
Reexamination

JUNG, II-HYUNG

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	111	7/8/2007	BKT
	112.06		
	112.07		
	112.08		
	114.01		
	114.03		
	114.05		
	114.06		
	114.09		
	114.12		
	114.18		
	121.02		
	127.05		
455	405-409		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST DATABASES SEARCH	7/8/2007	BKT